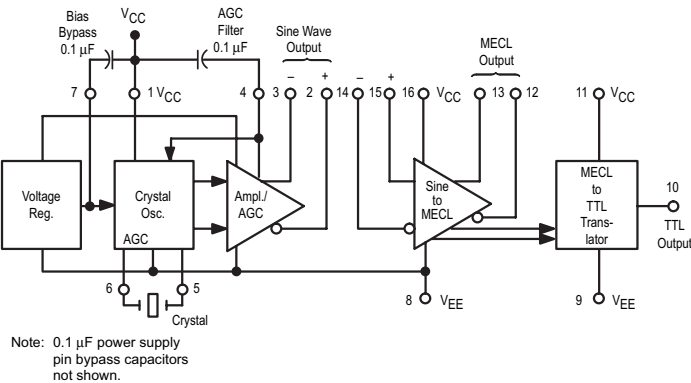


Legacy Device: *Motorola MC12561*

The ML12561 is the military temperature version of the commercial ML12061 device. It is for use with an external crystal to form a crystal controlled oscillator. In addition to the fundamental series mode crystal, two bypass capacitors are required (plus usual power supply pin bypass capacitors). Translators are provided internally for MECL and TTL outputs.

- Frequency Range = 2.0 to 20 MHz
- Operating Temperature Range $T_A = -55^{\circ}$ to $+125^{\circ}\text{C}$
- Single Supply Operation: +5.0 Vdc or -5.2 V DC
- Three Outputs Available:
 - 1.Complementary Sine Wave (600 mVpp typ)
 - 2.Complementary MECL
 - 3.Single Ended TTL

Figure 1. Block Diagram



TYPICAL CIRCUIT CONFIGURATIONS

Note: 0.1 μF power supply pin bypass capacitors not shown.

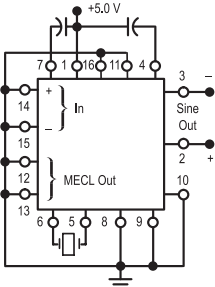


Figure 2. Sine Wave Output

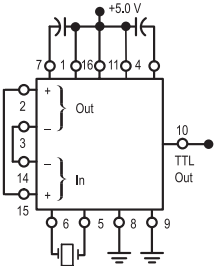


Figure 3. M TTL Output

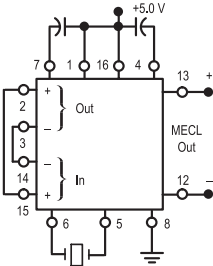


Figure 4. MECL Output
 (+5.0 V Supply)

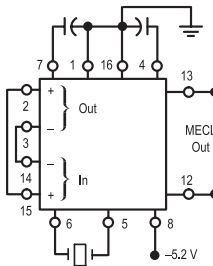
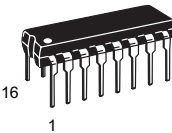


Figure 5. MECL Output
 (-5.2 V Supply)

CRYSTAL REQUIREMENTS
 Note: Start-up stabilization time is a function of crystal series resistance. The lower the resistance, the faster the circuit stabilizes.

Characteristic	ML12561/ML12561
Mode of Operation	Fundamental Series Resonance
Frequency Range	2.0 MHz — 20 MHz
Series Resistance, R1	Minimum at Fundamental
Maximum Effective Resistance $R_E(\text{max})$	155 ohms



CERDIP 16 = E
 CERAMIC PACKAGE
 CASE 620

CROSS REFERENCE/ORDERING INFORMATION

PACKAGE	MOTOROLA	LANSDALE
CERDIP 16	12561/BEA	ML12561/BEA

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Pin Under Test	Test Limits							Unit
			0°C		+25°C			+75°C		
			Min	Max	Min	Typ	Max	Min	Max	
Power Supply Drain Current	I _{CC}	1	—	—	13	16	19	—	—	mAdc
		1	—	—	18	23	28	—	—	
		11	—	—	—	3.0	4.0	—	—	
		16	—	—	13	16	19	—	—	
Input Current	I _{inH}	14	—	—	—	—	250	—	—	μAdc
		15	—	—	—	—	250	—	—	
	I _{inL}	14	—	—	—	—	1.0	—	—	μAdc
		15	—	—	—	—	1.0	—	—	
Differential Offset Voltage	ΔV	4 to 7	—	—	40	—	325	—	—	mAdc
		2 to 3	—	—	–200	0	+200	—	—	
Output Voltage Level	V _{out}	2	—	—	—	3.5	—	—	—	Vdc
		3	—	—	—	3.5	—	—	—	
Logic '1' Output Voltage	V _{OH1} (Note 1)	12	4.0	4.16	4.04	—	4.19	4.1	4.28	Vdc
	13	4.0	4.16	4.04	—	4.19	4.1	4.28		
	V _{OH2}	10	2.4	—	2.4	—	—	2.4	—	
Logic '0' Output Voltage	V _{OL1} (Note 1)	12	2.98	3.43	3.0	—	3.44	3.02	3.47	Vdc
		13	2.98	3.43	3.0	—	3.44	3.02	3.47	
	V _{OL2}	10	—	0.5	—	—	0.5	—	0.5	
		10	—	0.5	—	—	0.5	—	0.5	
Logic '1' Threshold Voltage	V _{OHA}	12	3.98	—	4.02	—	—	4.08	—	Vdc
		13	3.98	—	4.02	—	—	4.08	—	
Logic '0' Threshold Voltage	V _{OLA}	12	—	3.45	—	—	3.46	—	3.49	Vdc
		13	—	3.45	—	—	3.46	—	3.49	
Output Short Circuit Current	I _{OS}	10	20	60	20	—	60	20	60	mAdc

NOTE: 1. Devices will meet standard MECL logic levels using $V_{EE} = -5.2$ Vdc and $V_{CC} = 0$.

ELECTRICAL CHARACTERISTICS (continued)

@ Test Temperature			TEST VOLTAGE/CURRENT VALUES						Gnd	
			Volts							
			V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{IHT}	V _{CCCL}		
			0°C	4.16	3.19	3.86	3.51	4.0		4.75
			+25°C	4.19	3.21	3.90	3.52	4.0		4.75
+75°C	4.28	3.23	3.96	3.55	4.0	4.75				
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW						Gnd	
			V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{IHT}	V _{CCCL}		
Power Supply Drain Current	I _{CC}	1	—	—	—	—	—	—	8	
		1	—	—	—	—	—	—	8	
		11	14	15	—	—	—	—	8,9	
		16	—	—	—	—	—	—	8	
Input Current	I _{inH}	14	14	15	—	—	—	—	8	
		15	15	14	—	—	—	—	8	
	I _{inL}	14	15	—	—	—	—	—	8,14	
		15	14	—	—	—	—	—	8,15	
Differential Offset Voltage	ΔV	4 to 7 2 to 3	— —	— —	— —	— —	5,6 4	— —	8 —	
Output Voltage Level	V _{out}	2	—	—	—	—	4	—	8	
		3	—	—	—	—	4	—	8	
Logic '1' Output Voltage	V _{OH1} (Note 1)	12	14	15	—	—	—	—	8	
		13	15	14	—	—	—	—	8	
	V _{OH2}	10	15	14	—	—	—	11,16	8,9	
Logic '0' Output Voltage	V _{OL1} (Note 1)	12	15	14	—	—	—	—	8	
		13	14	15	—	—	—	—	8	
	V _{OL2}	10	14	15	—	—	—	11,16	8,9	
Logic '1' Threshold Voltage	V _{OHA}	12	—	—	14	15	—	—	8	
		13	—	—	15	14	—	—	8	
Logic '0' Threshold Voltage	V _{OLA}	12	—	—	15	14	—	—	8	
		13	—	—	14	15	—	—	8	
Output Short Circuit Current	I _{OS}	10	15	14	—	—	—	11,16	8,9,10	

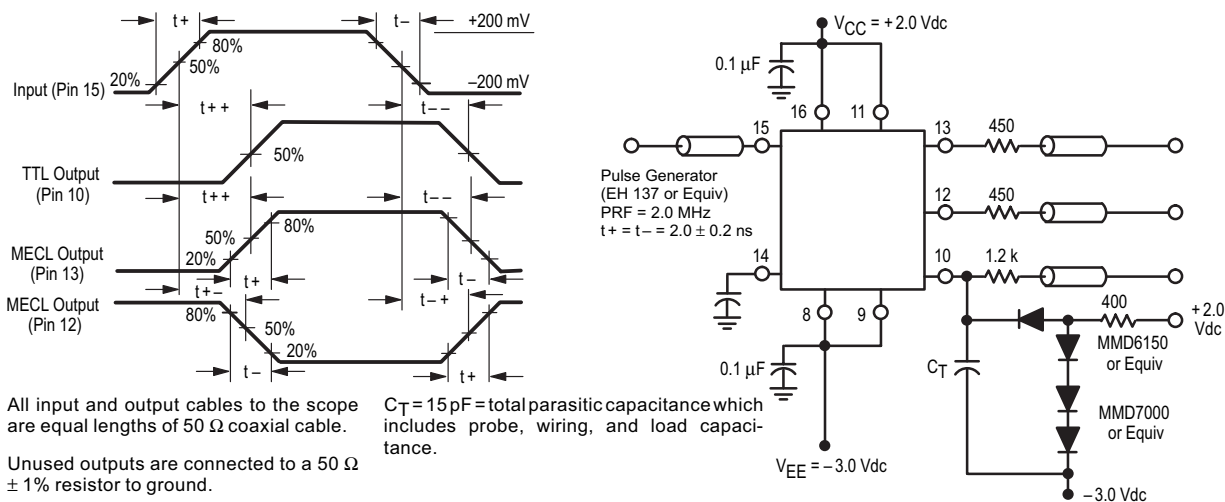
NOTE: 1. Devices will meet standard MECL logic levels using V_{EE} = –5.2 Vdc and V_{CC} = 0.

ELECTRICAL CHARACTERISTICS (continued)

@ Test Temperature			TEST VOLTAGE/CURRENT VALUES						
			Volts		mA				
			V _{CC}	V _{CCH}	I _{OL}	I _{OH}	I _{IL}		
			0°C	5.0	5.25	16	−0.4		−2.5
			+25°C	5.0	5.25	16	−0.4		−2.5
			+75°C	5.0	5.25	16	−0.4		−2.5
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW					Gnd	
			V _{CC}	V _{CCH}	I _{OL}	I _{OH}	I _{IL}		
Power Supply Drain Current	I _{CC}	1	1	−	−	−	−	8	
		1	1	−	−	−	−	8	
		11	11,16	−	−	−	−	8,9	
		16	16	−	−	−	−	8	
Input Current	I _{inH}	14	16	−	−	−	−	8	
		15	16	−	−	−	−	8	
	I _{inL}	14	16	−	−	−	−	8,14	
		15	16	−	−	−	−	8,15	
Differential Offset Voltage	ΔV	4 to 7 2 to 3	1 −	− −	− −	− −	− −	8 −	
Output Voltage Level	V _{out}	2	1	−	−	−	−	8	
		3	1	−	−	−	−	8	
Logic '1' Output Voltage	V _{OH1} (Note 1)	12 13	16 16	− −	− −	− −	12 13	8 8	
	V _{OH2}	10	−	−	−	10	−	8,9	
Logic '0' Output Voltage	V _{OL1} (Note 1)	12 13	16 16	− −	− −	− −	12 13	8 8	
	V _{OL2}	10 10	− −	− 11,16	10 10	− −	− −	8,9 8,9	
Logic '1' Threshold Voltage	V _{OHA}	12 13	16 16	− −	− −	− −	12 13	8 8	
Logic '0' Threshold Voltage	V _{OLA}	12 13	16 16	− −	− −	− −	12 13	8 8	
Output Short Circuit Current	I _{OS}	10	−	−	−	−	−	8,9,10	

NOTE: 1. Devices will meet standard MECL logic levels using V_{EE} = –5.2 Vdc and V_{CC} = 0.

Figure 6. AC Characteristics – MECL and TTL Outputs



Characteristic	Symbol	Pin Under Test	Test Limits							TEST VOLTAGES/WAVEFORMS APPLIED TO PINS LISTED BELOW:					Gnd
			0°C		+25°C			+75°C		Unit	Pulse In	Pulse Out	+2.0 Vdc	−3.0 Vdc	
			Min	Max	Min	Typ	Max	Min	Max						
Propagation Delay	t15+10+	10	—	22	—	17	25	—	27	ns	15	10	11,16	8,9	14
	t15−10−	10	—	19	—	12	18	—	18						
	t15+12−	12	—	5.2	—	4.3	5.5	—	5.8						
	t15−12+	12	—	5.0	—	3.7	5.2	—	5.2						
	t15+13+	13	—	4.8	—	4.0	5.0	—	5.2						
	t15−13−	13	—	5.0	—	4.0	5.0	—	5.1						
Rise Time	t12+	12	—	4.0	—	3.0	4.0	—	4.4	ns	15	12	11,16	8,9	14
	t13+	13	—	4.0	—	3.0	4.0	—	4.4	ns	15	13	11,16	8,9	14
Fall Time	t12−	12	—	4.0	—	3.0	4.0	—	4.0	ns	15	12	11,16	8,9	14
	t13−	13	—	4.0	—	3.0	4.0	—	4.0	ns	15	13	11,16	8,9	14

Characteristic	Pin Under Test	+25°C		Unit	TEST VOLTAGE APPLIED TO PINS LISTED BELOW	
		Min	Typ		+2.0 Vdc	−3.0 Vdc
Sine Wave Amplitude	2	650	750	mVp-p	1	8,9
	3	650	750			

Figure 7. AC Test Circuit – Sine Wave Output

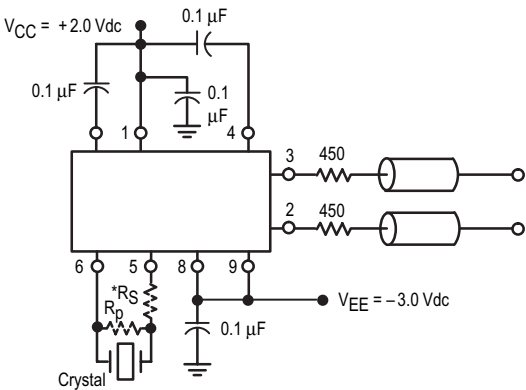
All output cables to the scope are equal lengths of 50 Ω coaxial cable. All unused cables must be terminated with a 50 Ω ± 1% resistor to ground.

450 Ω resistor and the scope termination impedance constitute a 10:1 attenuator probe.

Crystal — Reeves Hoffman Series Mode,
Series Resistance Minimum at Fundamental
f = 10 MHz
RE = 5 Ω

*RS = 15 kΩ is inserted only for test purposes. When used with the above specified crystal, it guarantees oscillation with any crystal which has an equivalent series resistance ≤ 155 Ω

RP: will improve start up problems value: 200–500 Ω



The ML12561 consists of three basic sections: an oscillator with AGC and two translators. Buffered complementary sine wave outputs are available from the oscillator section. The translators convert these sine wave outputs to levels compatible with MECL and/or TTL.

Series mode crystals should be used with the oscillator. If it is necessary or desirable to adjust the crystal frequency, a reactive element can be inserted in series with the crystal — an inductor to lower the frequency or a capacitor to raise it. When such an adjustment is necessary, it is recommended that the crystal be specified slightly lower in frequency and a series trimmer capacitor be added to bring the oscillator back on frequency. As the oscillator frequency is changed from the natural resonance of the crystal, more and more dependence is placed on the external reactance, and temperature drift of the trimming components then affects overall oscillator performance.

The ML12561 is designed to operate from a single supply — either +5.0 Vdc or -5.2 Vdc. Although each translator has separate VCC and VEE supply pins, the circuit is NOT designed to operate from both voltage levels at the same time. The separate VEE pin from the TTL translator helps minimize transient disturbance. If neither translator is being used, all unused pins (9 thru 16) should be connected to VEE (pin 8). With the translators not powered, supply current drain is typically reduced from 42 mA to 23 mA for the ML12061.

Frequency Stability

Output frequency of different oscillator circuits (of a given device type number) will vary somewhat when used with a given test setup. However, the variation should be within approximately $\pm 0.001\%$ from unit to unit. Frequency variations with temperature (independent of the crystal, which is held at 25°C) are small — about $-0.08\text{ppm}/^\circ\text{C}$ for ML12061 operating at 8.0 MHz.

Signal Characteristics

The sine wave outputs at either pin 2 or pin 3 will typically range from 800 mV_{p-p} (no load) to 500 mV_{p-p} (120 ohm AC load). Approximately 500 mV_{p-p} can be provided across 50 ohms by slightly increasing the DC current in the output buffer by the addition of an external resistor (680 ohms) from pin 2 or 3 to ground, as shown in Figure 9. Frequency drift is typically less than 0.0003% when going from a high-impedance load (1 megohm, 15pF) to the 50 ohm load of Figure 9. The DC voltage level at pin 2 or 3 is nominally 3.5 Vdc with VCC = +5.0 Vdc.

Harmonic distortion content in the sine wave outputs is crystal as well as circuit dependent. The largest harmonic (third) will usually be at least 15 dB down from the fundamental. The harmonic content is approximately load independent except

that the higher harmonic levels (greater than the fifth) are increased when the MECL translator is being driven.

Typically, the MECL outputs (pins 12 and 13) will drive up to five gates and the TTL output (pin10) will drive up to ten gates.

Noise Characteristics

Noise level evaluation of the sine wave outputs operation at or 9.0 MHz, indicates the following characteristics:

1. Noise floor (200 kHz from oscillator center frequency) is approximately -122 dB when referenced to a 1.0 Hz bandwidth. Noise floor is not sensitive to load conditions and/or translator operation.
2. Close-in noise (100 Hz from oscillator center frequency) is approximately -88 dB when referenced to a 1.0 Hz bandwidth.

Figure 8. Frequency Variation Due to Temperature

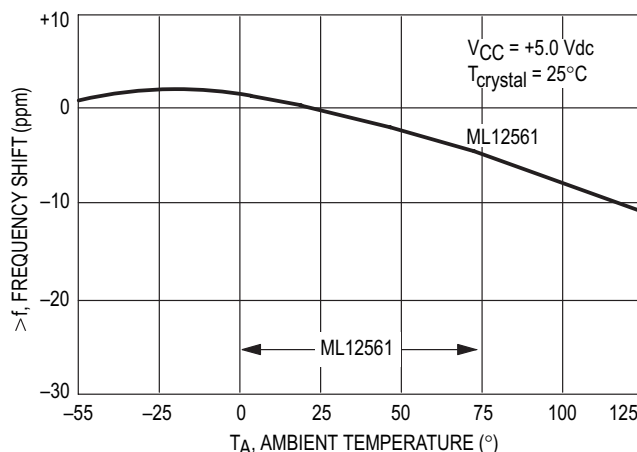
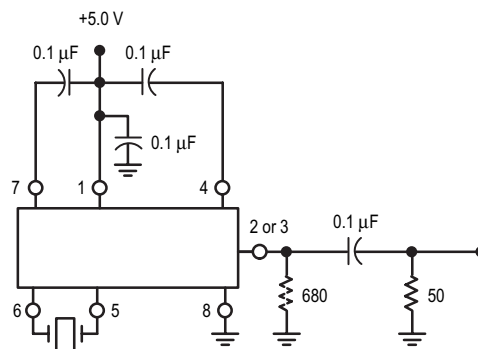


Figure 9. Driving Low Impedance Loads



* See text under signal characteristics.

Figure 10. MECL Translator Load Capability

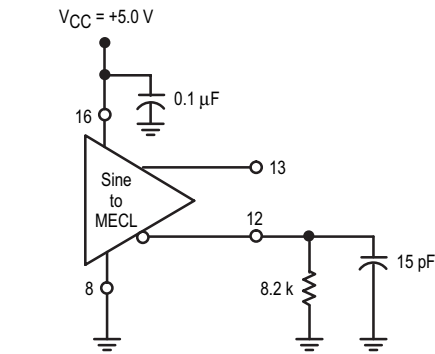


Figure 11. TTL Translator Load Capability

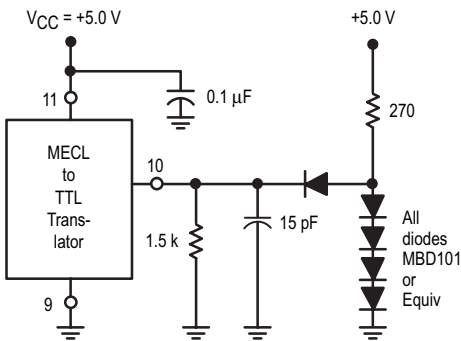
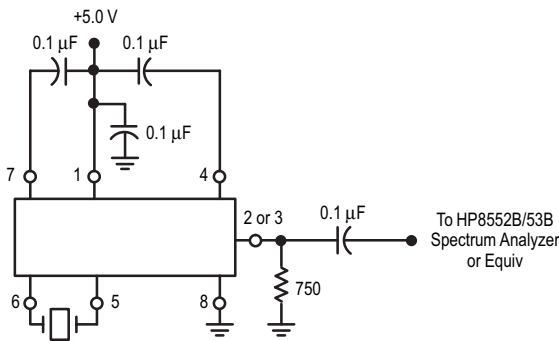
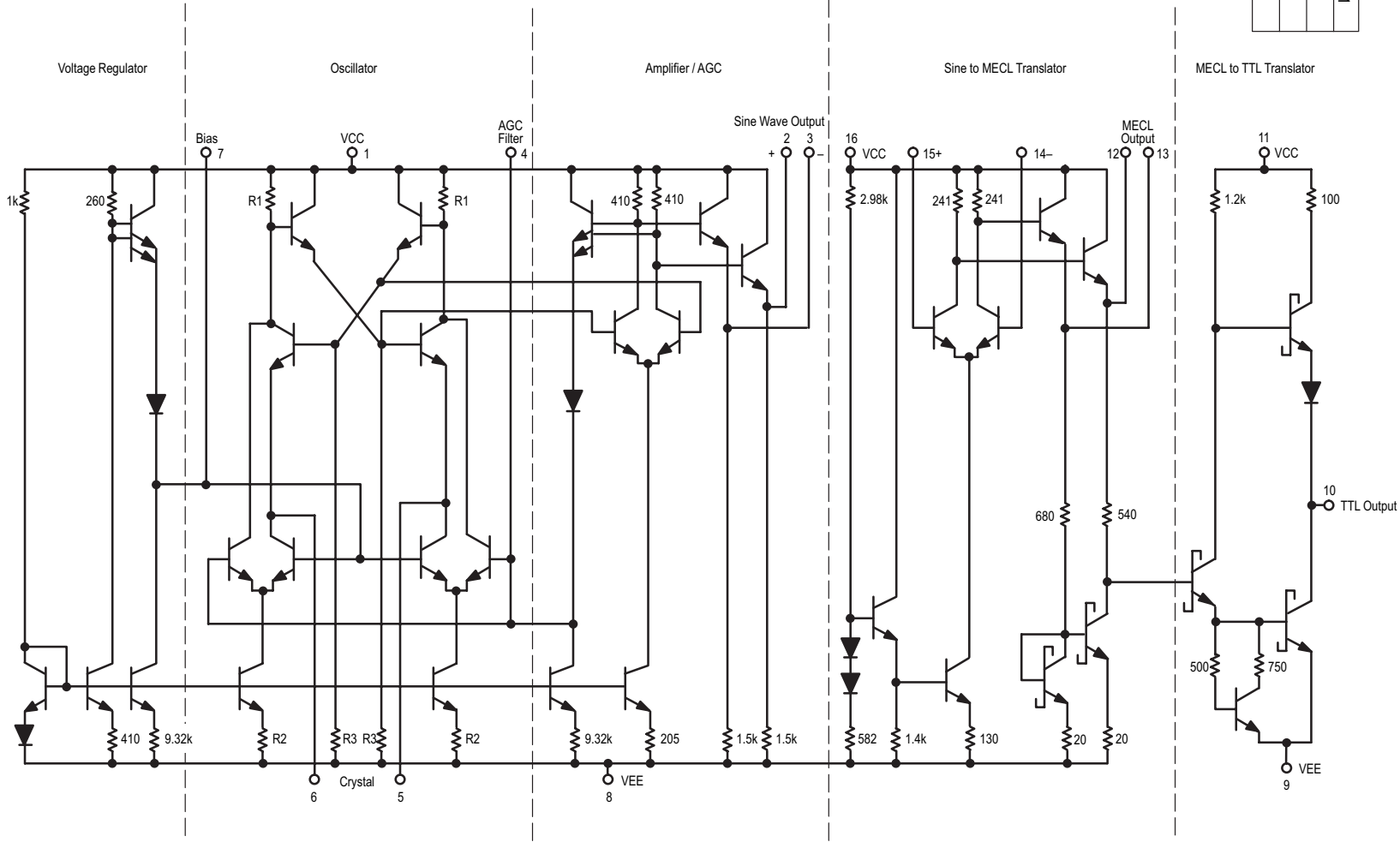


Figure 12. Noise Measurement Test Circuit



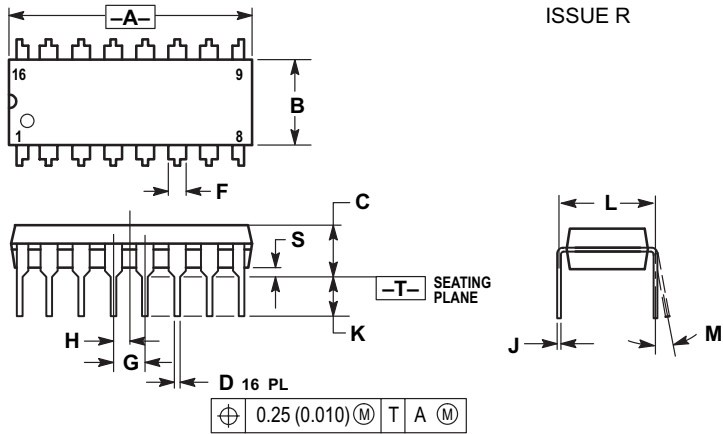
ANALYZER SETTING			
Measurement	Sweep	Bandwidth	Video Filter
Noise Floor	50 kHz/div	10 kHz	10 Hz
Close-In Noise	20 kHz/div	10 Hz	10 Hz

RESISTOR	ML12061
R1 (2 Places)	200 Ω
R2 (2 Places)	400 Ω
R3 (2 Places)	2 k Ω



OUTLINE DIMENSIONS

CERDIP 16 = E
CERAMIC PACKAGE
(ML12561/BEA)
CASE 620
ISSUE R



- NOTES:
- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 - 2. CONTROLLING DIMENSION: INCH.
 - 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
 - 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
 - 5. ROUNDED CORNERS OPTIONAL.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.740	0.770	18.80	19.55
B	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100 BSC		2.54 BSC	
H	0.050 BSC		1.27 BSC	
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0°	10°	0°	10°
S	0.020	0.040	0.51	1.01

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